

PBHV9050Z

500 V, 250 mA PNP high-voltage low V_{CEsat} (BISS) transistor

Rev. 1 — 19 August 2010 Product data she

Product data sheet

Product profile

1.1 General description

PNP high-voltage low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a medium power SOT223 (SC-73) Surface-Mounted Device (SMD) plastic package.

1.2 Features and benefits

- High voltage
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- AEC-Q101 qualified
- Medium power SMD plastic package

1.3 Applications

- Electronic ballasts
- LED driver for LED chain module
- LCD backlighting
- Automotive motor management
- Flyback converters
- Hook switch for wired telecom
- Switch Mode Power Supply (SMPS)

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CESM}	collector-emitter peak voltage	$V_{BE} = 0$	-	-	-500	V
V_{CEO}	collector-emitter voltage	open base	-	-	-500	V
I _C	collector current		-	-	-0.25	Α
h _{FE}	DC current gain	$V_{CE} = -10 \text{ V};$ $I_{C} = -50 \text{ mA}$	<u>[1]</u> 80	160	300	

^[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$



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2. Pinning information

Table 2. Pinning

	9		
Pin	Description	Simplified outline	Graphic symbol
1	base		
2	collector	4	2, 4
3	emitter		1—
4	collector		3
			sym028
			Symozo

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBHV9050Z	SC-73	plastic surface-mounted package with increased heat sink; 4 leads	SOT223

4. Marking

Table 4. Marking codes

3	
Type number	Marking code
PBHV9050Z	V9050Z

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-500	V
V_{CEO}	collector-emitter voltage	open base	-	-500	V
V _{CESM}	collector-emitter peak voltage	$V_{BE} = 0$	-	-500	V
V_{EBO}	emitter-base voltage	open collector	-	-6	V
I _C	collector current		-	-0.25	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-0.5	Α
I _{BM}	peak base current	single pulse; $t_p \le 1 \text{ ms}$	-	-200	mA

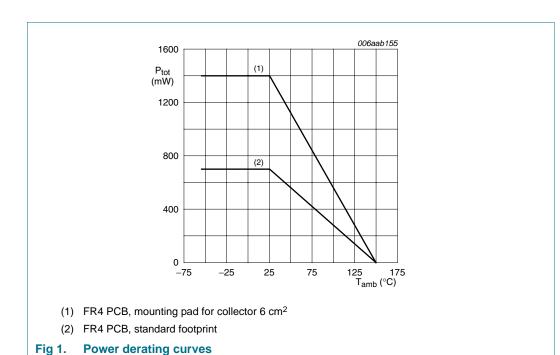
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Table 5. Limiting values ...continued
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	<u>[1]</u> -	700	mW
			[2] -	1400	mW
T _j	junction temperature		-	150	°C
T _{amb}	ambient temperature		-55	+150	°C
T _{stg}	storage temperature		-65	+150	°C

^[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for collector 6 cm².



Thermal characteristics

Table 6. Thermal characteristics

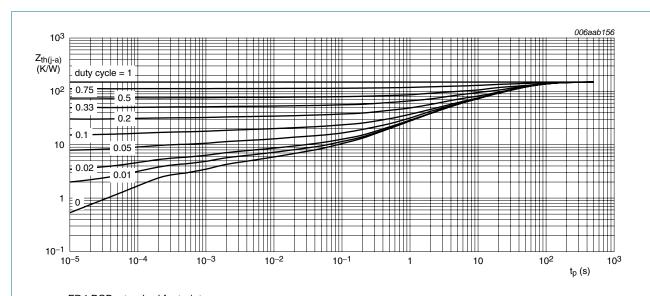
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> -	-	175	K/W
j	junction to ambient		[2] -	-	90	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		-	-	20	K/W

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

6.

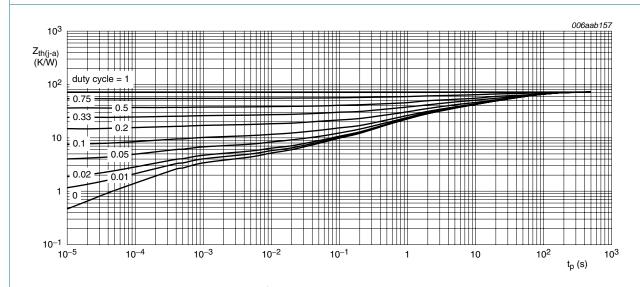
^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for collector 6 cm².

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FR4 PCB, standard footprint

Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for collector 6 cm²

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

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7. Characteristics

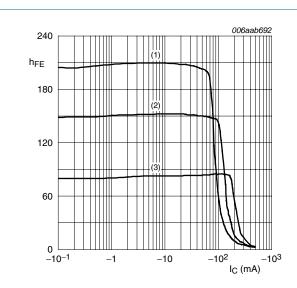
Table 7. Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = -360 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nA
	current	$V_{CB} = -360 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$	-	-	-10	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = -360 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -10 \text{ V}$				
		$I_C = -10 \text{ mA}$	100	160	300	
		$I_C = -50 \text{ mA}$	[1] 80	160	300	
		$I_{C} = -100 \text{ mA}$	[1] 70	150	-	
V _{CEsat}	collector-emitter	$I_C = -20 \text{ mA}; I_B = -2 \text{ mA}$	[1] -	-115	-200	mV
saturation voltage	saturation voltage	$I_C = -50 \text{ mA}; I_B = -10 \text{ mA}$	[1] -	-95	-200	mV
		$I_C = -100 \text{ mA};$ $I_B = -20 \text{ mA}$	<u>[1]</u> _	-140	-350	mV
V_{BEsat}	base-emitter saturation voltage	$I_C = -50 \text{ mA}; I_B = -10 \text{ mA}$	[1] -	-0.75	-0.9	V
t _d	delay time	$V_{CC} = -20 \text{ V};$	-	75	-	ns
t _r	rise time	¯ I _C = −0.05 A; − I _{Bon} = −5 mA;	-	1600	-	ns
t _{on}	turn-on time	$I_{Boff} = 10 \text{ mA}$	-	1675	-	ns
ts	storage time		-	1200	-	ns
t _f	fall time		-	550	-	ns
t _{off}	turn-off time		-	1750	-	ns
f _T	transition frequency	$V_{CE} = -10 \text{ V};$ $I_E = -10 \text{ mA}; f = 100 \text{ MHz}$	-	50	-	MHz
C _c	collector capacitance	$V_{CB} = -20 \text{ V}; I_E = I_e = 0 \text{ A};$ f = 1 MHz	-	6	-	pF
C _e	emitter capacitance	$V_{EB} = -0.5 \text{ V};$ $I_C = i_c = 0 \text{ A}; f = 1 \text{ MHz}$	-	170	-	pF

^[1] Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$

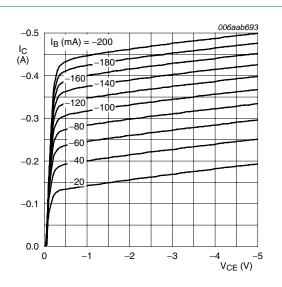
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$$V_{CE} = -10 \text{ V}$$

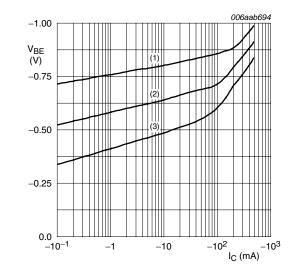
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \, ^{\circ}C$

Fig 4. DC current gain as a function of collector current; typical values



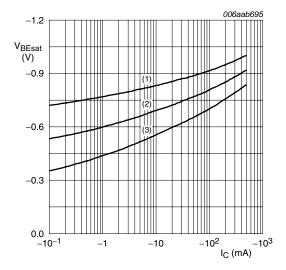
 $T_{amb} = 25 \, ^{\circ}C$

Fig 5. Collector current as a function of collector-emitter voltage; typical values



- $V_{CE} = -10 \text{ V}$
- (1) $T_{amb} = -55 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 6. Base-emitter voltage as a function of collector current; typical values

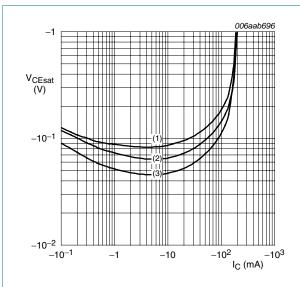


 $I_{\rm C}/I_{\rm B}=5$

- (1) $T_{amb} = -55 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 7. Base-emitter saturation voltage as a function of collector current; typical values

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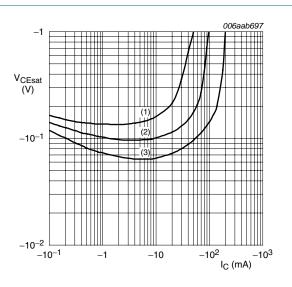
$$I_{\rm C}/I_{\rm B}=5$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3) $T_{amb} = -55 \, ^{\circ}C$

Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values



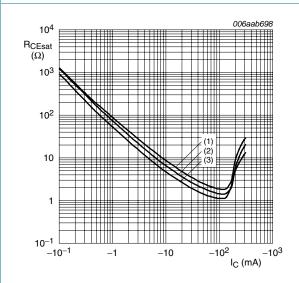
$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 20$$

(2)
$$I_C/I_B = 10$$

(3)
$$I_C/I_B = 5$$

Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



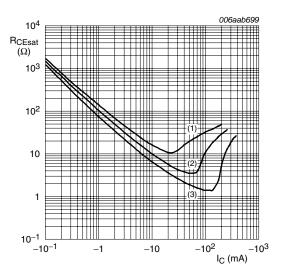
$$I_{\rm C}/I_{\rm B}=5$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values



(1)
$$I_C/I_B = 20$$

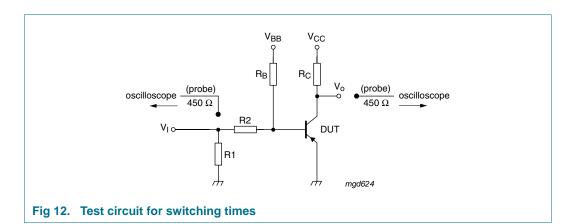
(2)
$$I_C/I_B = 10$$

(3)
$$I_C/I_B = 5$$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values

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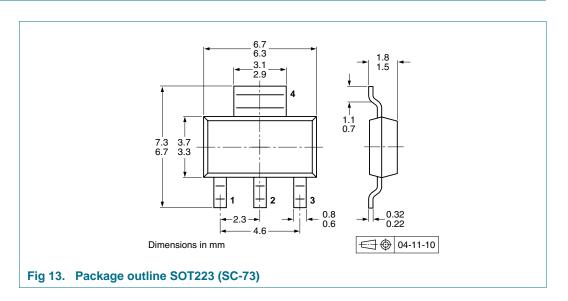
8. Test information



8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing o	Juantity
			1000	4000
PBHV9050Z	SOT223	8 mm pitch, 12 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see Section 14.

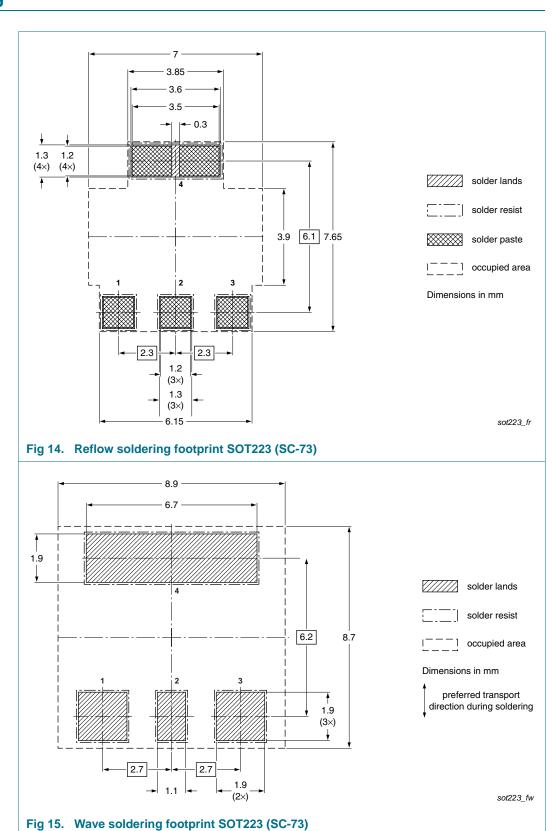
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11. Soldering



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12. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBHV9050Z v.1	20100819	Product data sheet	-	-

500 V, 250 mA PNP high-voltage low V_{CEsat} (BISS) transistor

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13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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